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Modulation Response of Semiconductor Quantum-Dot Lasers

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Introduction

A new expression of the modulation transfer function is derived for quantum dot (QD) lasers. The analytical approach is based on a cascade relaxation model taking into account three QD energy levels such as the wetting layer (WL), the 1st excited state (ES) as well as the ground state (GS). From the analysis, we demonstrate that the carrier escape from (GS) to (ES) is responsible for a non-zero resonance frequency at low bias powers.

Modulation Response based Analysis

The device under study consists of an InAs/InP(113)B QD laser [1]. As depicted in figure 1, the carrier dynamics in such lasers includes a direct relaxation channel from (WL) to (GS) [2]. Applying a small-signal analysis to the rate equations allows extracting a new expression of the QD laser's modulation response:

$$H(\omega) \equiv \frac{R_0}{R_0 + j\omega R_1 - \omega^2 R_2 - j\omega^3 R_3 + \omega^4} \quad (1)$$

with R_0, R_1, R_2 and R_3 parameters taking into account all the relevant QD constants such as the carrier escape term from (GS) to (ES) which is used to recast the relaxation frequency and damping factor definitions.

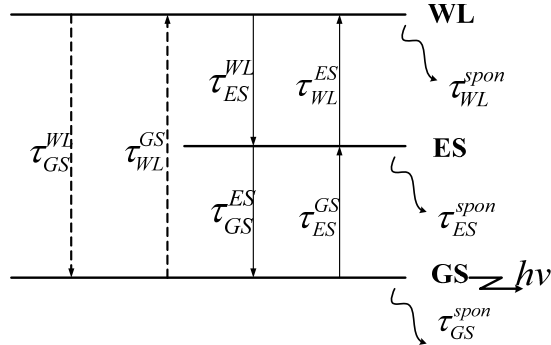


Fig.1. Illustration of carrier dynamics model with direct relaxation channel (dash line)

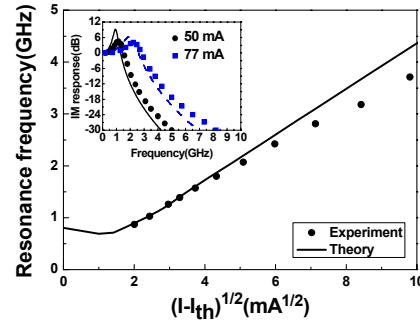


Fig.2. Resonance frequency and modulation response (inset) Solid lines are numerical and dots are experimental results.

Figure 2 show the measured squared resonance frequency (dots) as a function of the pump current deviation from the threshold value. Inset of figure 2 shows the experimental modulation response (dots) measured at two different pump currents. Numerical results obtained from (1) lead to a relative good agreement (solid) with the experiments. However, at large current injections, because the gain compression is not considered in our model, the calculated resonance frequency (solid) is found to be higher than the experimental results. Analytical calculations also point out that the carrier escape from (GS) to (ES) induces a non-zero resonance frequency at low bias powers. This frequency offset is larger than the one due to spontaneous emission only in quantum well (QW) lasers [3]. Similar behaviour is also observed when plotting the calculated damping factor as a function of the squared resonance frequency (not shown). Such a deviation from linearity at low resonance frequencies is also attributed to the carrier escape from (GS) to (ES), which leads to a larger damping factor offset as compared to conventional QW lasers [4].

Conclusions

A new analytical expression of the modulation response has been derived for a QD laser. From the analysis, it is found that at low bias powers, carrier escape from (GS) to (ES) provokes a non-zero resonance frequency associated to a stronger damping rate. These results are of first importance for a better understanding of the carrier dynamics in QD lasers for high-speed applications.

References

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